

**Notice of References Cited**

 Application/Control No.  
 10/079,286

 Applicant(s)/Patent Under  
 Reexamination  
 JEPSON ET AL.

 Examiner  
 Andrew L Oltmans

 Art Unit  
 1742  
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	C	US-6,331,233	12-2001	Turner, Stephen P.	204/298.13
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